Notice of References Cited Application/Control No. | Applicant(s)/Patent Under | Reexamination | LU ET AL. | Examiner | Art Unit | Wen W. Huang | 2618 | Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2003/0087653 A1	05-2003	Leung et al.	455/502
*	В	US-2003/0078044 A1	04-2003	Leung, Nikolai K.N.	455/502
*	С	US-6,256,508 B1	07-2001	Nakagawa et al.	455/502
*	D	US-5,101,501 A	03-1992	Gilhousen et al.	455/442
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0	-				
	Р					
	Q					
	R			,		
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.